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Contents

vii	Conference Committee
ix	Introduction

SESSION 1 3D SENSING: VIDEOMETRICS

- 649103 **3D surveillance system using multiple cameras** [6491-02]
A. K. Mishra, B. Ni, S. Winkler, A. Kassim, National Univ. of Singapore (Singapore)
- 649104 **On the performance evaluation of tracking systems using multiple pan-tilt-zoom cameras** [6491-03]
X. Desurmont, Multitel ASBL (Belgium); J. Hayet, Univ. of Liège (Belgium); C. Machy, J.-F. Delaigle, Multitel ASBL (Belgium); J.-F. Macq, UCL (Belgium)
- 649105 **Sensor configuration for coverage optimization in surveillance applications** [6491-04]
F. Janoos, R. Machiraju, R. Parent, J. W. Davis, A. Murray, The Ohio State Univ. (USA)

SESSION 2 3D SENSING: RANGE SENSING I

- 649106 **More than a poplar plank: the shape and subtle colors of the masterpiece *Mona Lisa* by Leonardo (Invited Paper)** [6491-05]
F. Blais, J. Taylor, L. Cournoyer, M. Picard, L. Borgeat, G. Godin, J.-A. Beraldin, M. Rioux, National Research Council Canada (Canada); C. Lahanier, B. Mottin, Ctr. de Recherche et de Restauration des Musées de France (France)
- 649107 **Low-cost characterization of 3D laser scanners** [6491-06]
M. Russo, G. Morlando, G. Guidi, Politecnico di Milano (Italy)
- 649108 **Metrological verification of 3D scanners: a preliminary approach** [6491-07]
R. Anchini, G. Di Leo, C. Liguori, A. Paolillo, A. Pietrosanto, Univ. of Salerno (Italy); G. Strazzullo, Fox Bit S.p.A. (Italy)

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- The last two digits indicate publication order within the volume using a Base 36 numbering system employing both numerals and letters. The CID number appears on each page of the manuscript. The complete citation is used on the first page, and an abbreviated version on subsequent pages.

- 649109 **TOF laser scanner characterization for low-range applications** [6491-08]
G. Guidi, Politecnico di Milano (Italy); C. Bianchini, Univ. of Rome La Sapienza (Italy)

SESSION 3 3D SENSING: RANGE SENSING II

- 64910A **Real-time range imaging by phase-stamp method using correlation image sensor** [6491-10]
A. Kimachi, Osaka Electro-Communication Univ. (Japan); S. Ando, The Univ. of Tokyo (Japan)
- 64910B **Traceable 3D imaging metrology** [6491-11]
J.-A. Beraldin, M. Rioux, L. Cournoyer, F. Blais, M. Picard, J. Pekelsky, National Research Council Canada (Canada)
- 64910C **Range imaging technology: new developments and applications for people identification and tracking** [6491-12]
T. Kahlmann, F. Remondino, S. Guillaume, ETH Zürich (Switzerland)
- 64910D **Heterodyne range imaging as an alternative to photogrammetry** [6491-13]
A. Dorrington, M. Cree, Univ. of Waikato (New Zealand); D. Carnegie, Victoria Univ. of Wellington (New Zealand); A. Payne, R. Conroy, Univ. of Waikato (New Zealand)

SESSION 4 3D PROCESSING AND MODELING

- 64910F **Content-based retrieval aided registration for texture images and range images** [6491-15]
E. Paquet, J.-A. Beraldin, National Research Council Canada (Canada)
- 64910G **A master-slaves volumetric framework for 3D reconstruction from images** [6491-16]
D. Ruiz, B. Macq, Univ. Catholique de Louvain (Belgium)
- 64910H **Data acquiring support system using recommendation degree map for 3D outdoor modeling** [6491-17]
T. Asai, M. Kanbara, N. Yokoya, Nara Institute of Science and Technology (Japan)
- 64910I **A multinational deployment of 3D laser scanning to study craniofacial dysmorphology in fetal alcohol spectrum disorders** [6491-18]
J. Rogers, E. Wernert, Indiana Univ. (USA); E. Moore, St. Vincent Hospital (USA); R. Ward, Indiana Univ. School of Liberal Arts (USA); L. F. Wetherill, T. Foroud, Indiana Univ. School of Medicine (USA)
- 64910J **Measurement and modeling of 4D live mouse heart volumes from CT time series** [6491-19]
A. W. Wetzel, Pittsburgh Supercomputing Ctr. (USA); C. T. Badea, Duke Univ. Medical Ctr. (USA); S. M. Pomerantz, Pittsburgh Supercomputing Ctr. (USA); N. Mistry, Duke Univ. Medical Ctr. (USA); D. Nave, Pittsburgh Supercomputing Ctr. (USA); G. A. Johnson, Duke Univ. Medical Ctr. (USA)

SESSION 5 MOTION ANALYSIS

- 64910K **Concepts of single highspeed-camera photogrammetric 3D measurement systems (Invited Paper)** [6491-20]
H.-G. Maas, Dresden Univ. of Technology (Germany)
- 64910L **Configuration of multimirror systems for single high-speed camera based 3D motion analysis** [6491-21]
T. Putze, Technische Univ. Dresden (Germany); K. Raguse, Volkswagen AG (Germany); H.-G. Maas, Technische Univ. Dresden (Germany)
- 64910M **Gait analysis in forensic medicine** [6491-22]
P. K. Larsen, E. B. Simonsen, N. Lynnerup, Univ. of Copenhagen (Denmark)

SESSION 6 INDUSTRY

- 64910O **3D body scanning technology for fashion and apparel industry** [6491-24]
N. D'Apuzzo, Homometrica Consulting (Switzerland)
- 64910P **Single CMOS sensor system for high resolution double volume measurement applied to membrane distillation system** [6491-25]
M. G. Lorenz, Univ. Carlos III (Spain); M. A. Izquierdo-Gil, Univ. Complutense (Spain); R. Sanchez-Reillo, Univ. Carlos III (Spain); C. Fernandez-Pineda, Univ. Complutense (Spain)
- 64910Q **Beyond inspection: the promise of videometrics for industry and engineering (Invited Paper)** [6491-26]
K. L. Edmundson, Geodetic Systems, Inc. (USA)

SESSION 7 CULTURAL HERITAGE

- 64910R **Active and passive sensors for art works analysis and investigations (Invited Paper)** [6491-27]
A. Pelagotti, Art-Test (Italy); A. Del Mastio, Univ. of Florence (Italy); A. V. Rationale, Univ. of Pisa (Italy)
- 64910S **The potential of 3D techniques for Cultural Heritage object documentation** [6491-28]
G. Bitelli, V. A. Girelli, Univ. of Bologna (Italy); F. Remondino, ETH Zürich (Switzerland); L. Vittuari, Univ. of Bologna (Italy)
- 64910T **Wood artworks monitoring through high-resolution 3D cameras** [6491-29]
G. Guidi, Politecnico di Milano (Italy); J.-A. Beraldin, National Research Council Canada (Canada); C. Atzeni, Univ. of Florence (Italy)
- 64910U **Digital documentation of complex architectures by integration of multiple techniques: the case study of Valer Castle** [6491-30]
F. Voltolini, ITC-IRST (Italy); S. El-Hakim, National Research Council (Canada); F. Remondino, ETH Zurich (Switzerland); S. Girardi, A. Rizzi, M. Pontin, L. Gonzo, ITC-IRST (Italy)

SESSION 8 VISUALIZATION

- 64910V **Performance evaluation of a coded structural light system for cultural heritage applications** [6491-31]
D. Akca, F. Remondino, D. Novák, T. Hanusch, G. Schrotter, A. Gruen, ETH Zürich (Switzerland)
- 64910W **A solid texture analysis based on three-dimensional convolution kernels** [6491-32]
M. T. Suzuki, Y. Yaginuma, National Institute of Multimedia Education (Japan)
- 64910X **Acquisition of three-dimensional coordinates of objects from Axi-Vision image data and application to stereoscopic display using integral photography system** [6491-33]
T. Aida, A. Yoneda, T. Uragaki, Osaka City Univ. (Japan); M. Kawakita, Japan Broadcasting Corp. (Japan)
- 64910Y **Crack propagation imaging by the ISIS camera and a video trigger system** [6491-34]
T. Okinaka, P. Karimov, T. Etoh, Kinki Univ. (Japan); K. Oguni, Univ. of Tokyo (Japan)

POSTER SESSION

- 64910Z **Variability of bodily measures of normally dressed people using PhotoModeler Pro.** [6491-39]
P. K. Larsen, Univ. of Copenhagen (Denmark); L. Hansen, National Institute of Occupational Health (Denmark); E. B. Simonsen, N. Lynnerup, Univ. of Copenhagen (Denmark)
- 649110 **Subpixel location of discrete target images in close-range camera calibration: a novel approach** [6491-40]
R. Anchini, Univ. of Salerno (Italy); J. A. Beraldin, National Research Council Canada (Canada); C. Liguori, Univ. of Salerno (Italy)
- 649111 **Design of an image sensor for an ultra-high-speed and ultra-high-sensitive video microscope** [6491-42]
N. Otsuka, V. L. Cuong, P. Karimov, K. Takehara, T. G. Etoh, Kinki Univ. (Japan)
- 649112 **Performance analysis and parameter optimization for iris recognition using Log-Gabor wavelet** [6491-43]
V. A. Pozdin, Y. Du, Indiana Univ.-Purdue Univ. (USA)

Author Index

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Session Chairs

- 1 3D Sensing: Videometrics
Hans-Gerd Maas, Technische Universität Dresden (Germany)
- 2 3D Sensing: Range Sensing I
J.-Angelo Beraldin, National Research Council Canada (Canada)
- 3 3D Sensing: Range Sensing II
François Blais, National Research Council Canada (Canada)
- 4 3D Processing and Modeling
Fabio Remondino, ETH Zürich (Switzerland)

- 5 Motion Analysis
 Fabio Remondino, ETH Zürich (Switzerland)
- 6 Industry
 Gabriele Guidi, Politecnico di Milano (Italy)
- 7 Cultural Heritage
 Mark R. Shortis, Royal Melbourne Institute of Technology (Australia)
- 8 Visualization
 Nicola D'Apuzzo, Homometrica Consulting (Switzerland)

Introduction

This Videometrics conference is 11th in a series begun in 1991. Under the auspices of SPIE—The International Society for Optical Engineering, Sabry El-Hakim arranged the first conference on Industrial Vision Metrology at Winnipeg in Canada. Based on the success of this first venture into the emerging discipline, the conference was renamed Videometrics and held in conjunction with the SPIE Photonics East symposium in Boston and Philadelphia during 1992–1995. Videometrics was then relocated among the approximately 20 conferences composing the IS&T/SPIE Electronic Imaging symposium (jointly sponsored by IS&T—Society for Imaging Science and Technology and SPIE), collocated with SPIE's Photonics West event held annually in California. The conferences were held once in San Diego, in 1997, then twice in San Jose, in 1999 and 2000, and given the longer title of "Videometric and Optical Methods for 3D Shape Measurement."

In 2003, Electronic Imaging was geographically separated from Photonics West, primarily because the event had become too large to be easily accommodated in available convention facilities in California. Electronic Imaging was held in Santa Clara in 2003, and moved back to San Jose in 2005. Since then the two symposia both have been held in San Jose, but in consecutive weeks.

The Electronic Imaging conferences combine the disciplines of 3D imaging, visualisation, image processing, digital image sensors, multimedia processing, and video communications. Although the individual conferences generally span one to three days, the schedule is staggered so that there is a selection of 15–20 technical sessions at any time during the meeting. Attendees thereby get the benefit of seeing the broader extent of discipline areas allied to Videometrics.

During the last 15 years, Videometrics has provided a unique forum for computer vision and photogrammetry practitioners to present the latest advances in precise 3D measurement and modelling from imaging and range sensors. Videometrics was originally focused on the metric performance of sensors and algorithms to produce the most accurate and reliable geometric measurements and models. Topics such as sensor calibration, performance evaluation, and accurate object reconstruction were paramount. This has now been expanded to encompass all phases of 3D imaging and modelling of real scenes including automation of data collection and processing, improving the visual quality and realism, visualization, animation, and data management for real-time manipulation. This is in response to the rapidly growing interest in 3D imaging and modelling technology, and the increase in demand of such models in applications such as rapid product development, virtual museums, documentation of monuments and architecture for cultural heritage, marketing

and tourism, human body modelling, medicine, and exploration of remote and hazardous sites, to name a few.

The chairs of Videometrics welcome and acknowledge the efforts of the authors, presenters, and audience in maintaining the high level of interest in Videometrics and contributing to the success of the meeting.

J.-Angelo Beraldin
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